



APSEMI

AC3M0015065K

Silicon Carbide Power MOSFET
N-Channel Enhancement Mode

Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating ; RoHS compliant

Parameter	Rating	Units
V_{DS}	650	V
$I_D @ 25^\circ C$	122	A
$R_{DS(on)}$	15	m Ω



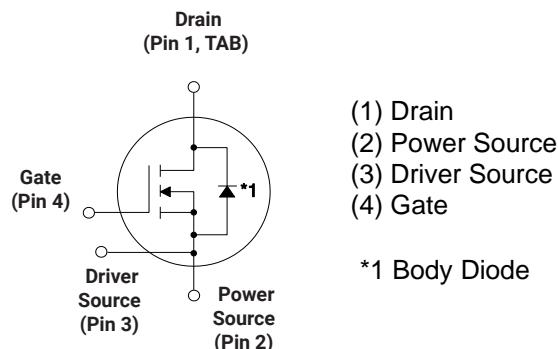
Applications

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- Induction heating



TO-247-4
Package

Inner circuit



- (1) Drain
(2) Power Source
(3) Driver Source
(4) Gate

*1 Body Diode

Maximum Ratings ($T_c=25^\circ C$, unless otherwise specified)

Symbol	Parameter	Value	Unit	Note
V_{DSmax}	Drain - Source Voltage	650	V	
V_{GSmax}	Gate - Source voltage	-8/+19	V	
I_D	Continuous Drain Current, $V_{GS} = 15 V$, $T_c = 25^\circ C$	122	A	
	Continuous Drain Current, $V_{GS} = 15 V$, $T_c = 100^\circ C$	98		
$I_{D(pulse)}$	Pulsed Drain Current, Pulse width t_p limited by T_{jmax}	430	A	
P_D	Power Dissipation, $T_c=25^\circ C$, $T_j = 175^\circ C$	420	W	
T_j, T_{stg}	Operating Junction and Storage Temperature	-40 to +175	°C	
T_L	Solder Temperature, 1.6mm (0.063") from case for 10s	260	°C	
M_d	Mounting Torque, (M3 or 6-32 screw)	1 8.8	Nm lbf-in	

Note (1): Recommended turn off / turn on gate voltage V_{GS} - 4V...0V / +15V

Note (2): Package limited to 120 A

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.3	3.6	V	$V_{DS} = V_{GS}, I_D = 15.5 \text{ mA}$	
			1.9		V	$V_{DS} = V_{GS}, I_D = 15.5 \text{ mA}, T_J = 175^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	
I_{GSS}	Gate-Source Leakage Current		10	255	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$	
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	10.5	15	21	$\text{m}\Omega$	$V_{GS} = 15 \text{ V}, I_D = 55.8 \text{ A}$	
			20			$V_{GS} = 15 \text{ V}, I_D = 55.8 \text{ A}, T_J = 175^\circ\text{C}$	
g_{fs}	Transconductance		42		S	$V_{DS} = 20 \text{ V}, I_{DS} = 55.8 \text{ A}$	
			40			$V_{DS} = 20 \text{ V}, I_{DS} = 55.8 \text{ A}, T_J = 175^\circ\text{C}$	
C_{iss}	Input Capacitance		4960		pF		
C_{oss}	Output Capacitance		290			$V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V}$	
C_{rss}	Reverse Transfer Capacitance		31			$f = 100 \text{ KHz}$	
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		353			$V_{AC} = 25 \text{ mV}$	
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		516				
E_{oss}	C_{oss} Stored Energy		29		μJ		
E_{ON}	Turn-On Switching Energy (Body Diode)		401		μJ	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 55.8 \text{ A}, R_{G(\text{ext})} = 5 \Omega, L = 57.6 \mu\text{H}, T_J = 175^\circ\text{C}$	
E_{OFF}	Turn Off Switching Energy (Body Diode)		254			FWD = Internal Body Diode of MOSFET	
E_{ON}	Turn-On Switching Energy (External Diode)		234		μJ	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 55.8 \text{ A}, R_{G(\text{ext})} = 5 \Omega, L = 57.6 \mu\text{H}, T_J = 175^\circ\text{C}$	
E_{OFF}	Turn Off Switching Energy (External Diode)		310			FWD = External SiC DIODE	
$t_{d(on)}$	Turn-On Delay Time		25		ns		
t_r	Rise Time		32			$V_{DD} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	
$t_{d(off)}$	Turn-Off Delay Time		60			$I_D = 55.8 \text{ A}, R_{G(\text{ext})} = 5 \Omega, L = 57.6 \mu\text{H}$	
t_f	Fall Time		15			Timing relative to V_{DS} Inductive load	
$R_{G(\text{int})}$	Internal Gate Resistance		1.5		Ω	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$	
Q_{gs}	Gate to Source Charge		53		nC	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	
Q_{gd}	Gate to Drain Charge		62			$I_D = 55.8 \text{ A}$	
Q_g	Total Gate Charge		190			Per IEC60747-8-4 pg 21	

Note (3): $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V
 $C_{o(tr)}$, a lumped capacitance that gives same charging time as C_{oss} while V_{DS} is rising from 0 to 400V

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.7		V	$V_{GS} = -4 \text{ V}, I_{SD} = 27.9 \text{ A}, T_j = 25^\circ\text{C}$	
		4.2		V	$V_{GS} = -4 \text{ V}, I_{SD} = 27.9 \text{ A}, T_j = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		80	A	$V_{GS} = -4 \text{ V}, T_c = 25^\circ\text{C}$	
$I_{S,pulse}$	Diode pulse Current		223	A	$V_{GS} = -4 \text{ V}$, pulse width t_p limited by T_{jmax}	
t_{rr}	Reverse Recover time	22		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 55.8 \text{ A}, V_R = 400 \text{ V}$ $dif/dt = 4000 \text{ A}/\mu\text{s}, T_j = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	510		nC		
I_{rrm}	Peak Reverse Recovery Current	39		A		
t_{rr}	Reverse Recover time	26		ns		
Q_{rr}	Reverse Recovery Charge	435		nC	$V_{GS} = -4 \text{ V}, I_{SD} = 55.8 \text{ A}, V_R = 400 \text{ V}$ $dif/dt = 2500 \text{ A}/\mu\text{s}, T_j = 175^\circ\text{C}$	
I_{rrm}	Peak Reverse Recovery Current	28		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
R_{0JC}	Thermal Resistance from Junction to Case	0.35	°C/W		
R_{0JA}	Thermal Resistance From Junction to Ambient	40			



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Package Dimensions

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